# Search Notes



Ap	plic	ation	/Con	trol	No

10542612

Examiner

Jeffers, Benjamin

# Applicant(s)/Patent Under Reexamination

IKURA ET AL.

Art Unit

2629

## **SEARCHED**

Class	Subclass	Date	Examine
345	60-72	9/24/2007	BJ
345	207	9/24/2007	BJ
345	209	9/20/2007	BJ
315	169.1	9/20/2007	BJ

### **SEARCH NOTES**

Search Notes	Date	Examiner
Inventor name search through PALM	9/19/2007	BJ
Searched for art including cell/pixel test method	9/20/2007	BJ
Including adjacent cells	9/20/2007	BJ
in specific subclasses	9/24/2007	BJ

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

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